NTBGS001N06C

Product Preview **Power MOSFET** 60 V, 1.0 m Ω , 363 A, Single N-Channel, D²PAK7

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- Lowers Switching Noise/EMI
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Typical Applications

- Power Tools, Battery Operated Vacuums
- UAV/Drones, Material Handling
- BMS/Storage, Home Automation

MAXIMUM RATINGS (T_J = $25^{\circ}C$ unless otherwise noted)

| Parameter | | | Symbol | Value | Unit |
|--|---------------------|----------------------------|-----------------------------------|-----------------|------|
| Drain-to-Source Voltage | | | V _{DSS} | 60 | V |
| Gate-to-Source Voltage | Э | | V _{GS} | ±20 | V |
| $\begin{array}{l} \text{Continuous Drain} \\ \text{Current } R_{\theta JC} \\ \text{(Note 2)} \end{array}$ | Steady State | T _C = 25°C | Ι _D | 363 | A |
| Power Dissipation $R_{\theta JC}$ (Note 2) | Oldic | | P _D | 250 | W |
| Continuous Drain Current R _{θJA} (Notes 1, 2) | Steady State | T _A = 25°C | Ι _D | 44 | A |
| Power Dissipation $R_{\theta JA}$ (Notes 1, 2) | State | | P _D | 3.8 | W |
| Pulsed Drain Current | T _A = 25 | °C, t _p = 10 μs | I _{DM} | TBD | А |
| Operating Junction and Storage Temperature | | | T _J , T _{stg} | –55 to + 175 | °C |
| Source Current (Body Diode) | | | ۱ _S | TBD | А |
| Single Pulse Drain-to-Source Avalanche Energy ($I_L = TBD A_{pk}, L = TBD mH$) | | | E _{AS} | TBD | mJ |
| Lead Temperature for Soldering Purposes (1/8" from case for 10 s) | | | ΤL | 260 | °C |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface-mounted on FR4 board using a 1 in², 1 oz. Cu pad.

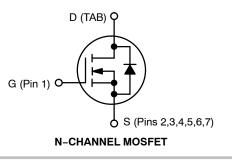
The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

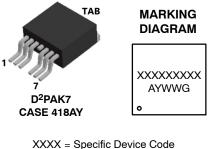


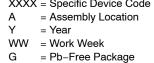
ON Semiconductor®

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| V _{(BR)DSS} | R _{DS(ON)} MAX | I _D MAX |
|----------------------|-------------------------|--------------------|
| 60 V | 1.0 m Ω @ 10 V | 363 A |
| 00 V | TBD m Ω @ 6 V | 000 A |







ORDERING INFORMATION

| Device | Package | Shipping [†] |
|--------------|----------------------------------|-----------------------|
| NTBGS001N06C | D ² PAK7 (Pb-Free) | 800 / Tape & Reel |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

This document contains information on a product under development. ON Semiconductor reserves the right to change or discontinue this product without notice.

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THERMAL RESISTANCE MAXIMUM RATINGS

| Parameter | Symbol | Value | Unit |
|---|---------------------|-------|------|
| Junction-to-Case - Steady State (Note 2) | $R_{	ext{	heta}JC}$ | 0.6 | °C/W |
| Junction-to-Ambient - Steady State (Note 2) | $R_{	ext{	heta}JA}$ | 40 | |

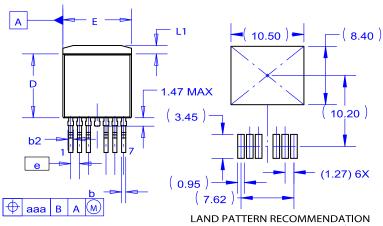
ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise specified)

| Parameter | Symbol | Test Condition | | Min | Тур | Max | Unit |
|--|--|---|--|-----|----------|-----|-------|
| OFF CHARACTERISTICS | | | | | | | |
| Drain-to-Source Breakdown Voltage | V _{(BR)DSS} | V_{GS} = 0 V, I _D = 250 μ A | | 60 | | | V |
| Drain-to-Source Breakdown Voltage Temperature Coefficient | V _{(BR)DSS} / T _J | $I_D = 562 \ \mu$ A, ref to 25°C | | | TBD | | mV/°C |
| Zero Gate Voltage Drain Current | I _{DSS} | $V_{GS} = 0 V$, $T_J = 25^{\circ}C$ | | | | 10 | μA |
| | | V _{DS} = 60 V | T _J = 125°C | | | 100 | μA |
| Gate-to-Source Leakage Current | I _{GSS} | V _{DS} = 0 V, V _{GS} | = 20 V | | | 100 | nA |
| ON CHARACTERISTICS (Note 3) | | | | | | | |
| Gate Threshold Voltage | V _{GS(TH)} | V _{GS} = V _{DS} , I _D = | = 562 μA | 2.0 | 3.0 | 4.0 | V |
| Negative Threshold Temperature Coefficient | V _{GS(TH)} /T _J | I _D = 562 μA, ref | to 25°C | | TBD | | mV/°C |
| Drain-to-Source On Resistance | R _{DS(on)} | V _{GS} = 10 V, I _D = 112 A | | | TBD | 1.0 | |
| | | V _{GS} = 6 V, I _D | = 56 A | | TBD | | mΩ |
| Forward Transconductance | 9 FS | V _{DS} = 5 V, I _D = | = 112 A | | TBD | | S |
| Gate-Resistance | R _G | T _A = 25° | С | | 1.0 | | Ω |
| CHARGES, CAPACITANCES & GATE RESIS | TANCE | | | | | | |
| Input Capacitance | C _{ISS} | | | | 9628 | | pF |
| Output Capacitance | C _{OSS} | V _{GS} = 0 V, V _{DS} = 30 | V _{GS} = 0 V, V _{DS} = 30 V, f = 1 MHz | | 5719 | | |
| Reverse Transfer Capacitance | C _{RSS} | | | | 53 | | |
| Total Gate Charge | Q _{G(TOT)} | | | | 119 | | 1 |
| Threshold Gate Charge | Q _{G(TH)} | | | | TBD | | 1 |
| Gate-to-Source Charge | Q _{GS} | V_{GS} = 10 V, V_{DS} = 30 V; I_{D} = 112 A | | | 41 | | nC |
| Gate-to-Drain Charge | Q _{GD} | | | | 18 | | |
| Total Gate Charge | Q _{G(TOT)} | | | | TBD | | |
| SWITCHING CHARACTERISTICS (Note 4) | <u> </u> | | | | <u> </u> | | |
| Turn-On Delay Time | t _{d(ON)} | | | | TBD | | |
| Rise Time | tr | Vcc - 10 V Vcc | - 30 V | | TBD | | 1 |
| Turn-Off Delay Time | t _{d(OFF)} | V_{GS} = 10 V, V_{DS} = 30 V, I_{D} = 112 A, R_{G} = 6 Ω | | | TBD | | ns |
| Fall Time | t _f | | | | TBD | | |
| DRAIN-SOURCE DIODE CHARACTERISTIC | s | | | | | | |
| Forward Diode Voltage | ward Diode Voltage V _{SD} | | T _J = 25°C | | TBD | 1.2 | |
| | | V _{GS} = 0 V, I _S = 112 A | T _J = 125°C | | TBD | | V |
| Reverse Recovery Time | t _{RR} | V _{GS} = 0 V, dI _S /dt = 100 A/µs, I _S = 56 A | | | TBD | | |
| Charge Time | ta | | | | TBD | | ns |
| Discharge Time | t _b | | | | TBD | | |
| Reverse Recovery Charge | Q _{RR} | | | | TBD | | nC |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 3. Pulse Test: pulse width \leq 300 µs, duty cycle \leq 2%. 4. Switching characteristics are independent of operating junction temperatures.

PACKAGE DIMENSIONS

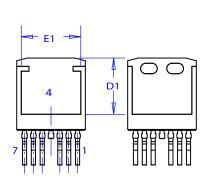
D²PAK7 (TO-263 7 LD) CASE 418AY **ISSUE B**



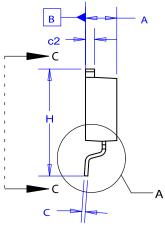
NOTES:

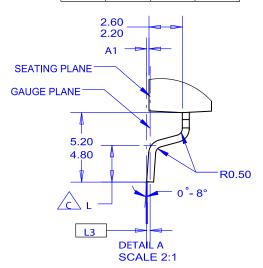
- A. PACKAGE CONFORMS TO JEDEC TO-263 VARIATION CB EXCEPT WHERE NOTED. B. ALL DIMENSIONS ARE IN MILLIMETERS.
- OUT OF JEDEC STANDARD VALUE.
 D. DIMENSION AND TOLERANCE AS PER ASME Y14.5-1994.
 E. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS.
 F. LAND PATTERN RECOMMENDATION PER IPC. TO127P1524X465-8N.

| | MILLIMETERS | | | | | |
|-----|-------------|-------|-------|--|--|--|
| DIM | MIN | NOM | MAX | | | |
| А | 4.30 | 4.50 | 4.70 | | | |
| A1 | 0.00 | 0.10 | 0.20 | | | |
| b2 | 0.70 | 0.80 | 0.90 | | | |
| b | 0.51 | 0.60 | 0.70 | | | |
| С | 0.40 | 0.50 | 0.60 | | | |
| c2 | 1.20 | 1.30 | 1.40 | | | |
| D | 9.00 | 9.20 | 9.40 | | | |
| D1 | 6.70 | 6.80 | 6.95 | | | |
| Е | 9.70 | 9.90 | 10.20 | | | |
| E1 | 7.80 | 7.90 | 8.00 | | | |
| е | ~ | 1.27 | 1 | | | |
| H | 15.10 | 15.40 | 15.70 | | | |
| L | 2.44 | 2.64 | 2.84 | | | |
| L1 | 1.00 | 1.20 | 1.40 | | | |
| L3 | ~ | 0.25 | ~ | | | |
| aaa | ~ | ~ | 0.25 | | | |



OPTIONAL CONSTRUCTIONS VIEW C-C SCALE 2 : 1





NTBGS001N06C

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